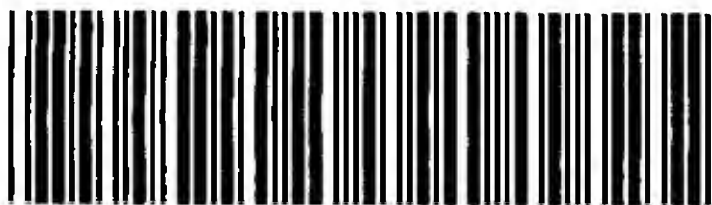


Search Notes

Application/Control No.

10/531,697

Examiner

Mark Kopec

Applicant(s)/Patent under
Reexamination

YAMAKAWA ET AL.

Art Unit

1751

SEARCHED

Class	Subclass	Date	Examiner
252	512	9/2/2007	M.K.
252	514		
106	1.18, 1.2		
75	255		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Inv. Name Search	9/2/2007	M.K.
EAST		
Rev 210 and Supp 210		